

Notice of References Cited	Application/Control No. 10/623,550	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner David T. Beck	Art Unit 1732	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
★	A	US-6,329,058	12-2001	Arney et al.	428/403
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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